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Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/810,416	CHEN, LU	
Examiner	Art Unit	_
Dean O. Takaoka	2817	

SEARCHED			
Class	Subclass	Date	Examiner
333	101	8/30/2006	DT
333	109	8/30/2006	DŢ
333	116	8/30/2006	DT
updated	above	1/17/2007	DT
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
all above		1/17/2007	DT

SEARCH NOT (INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
east attached	8/30/2006	DT -	
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